

Normally – OFF Silicon Carbide Junction Transistor

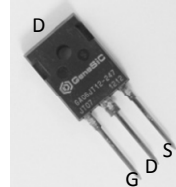
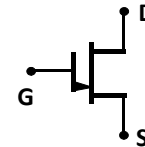
$-V_{DS}$	=	1200 V
$V_{DS(ON)}$	=	1.3 V
I_D	=	6 A
$R_{DS(ON)}$	=	220 mΩ

Features

- 175 °C maximum operating temperature
- Temperature independent switching performance
- Gate oxide free SiC switch
- Suitable for connecting an anti-parallel diode
- Positive temperature coefficient for easy paralleling
- Low gate charge
- Low intrinsic capacitance

Package

- RoHS Compliant


TO-247AB


Advantages

- Low switching losses
- Higher efficiency
- High temperature operation
- High short circuit withstand capability

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Maximum Ratings unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Drain – Source Voltage	V_{DS}	$V_{GS} = 0 V$	1200	V
Continuous Drain Current	I_D	$T_{C,MAX} = 90 °C$	6	A
Gate Peak Current	I_{GM}		5	A
Turn-Off Safe Operating Area	RBSOA	$T_{VJ} = 175 °C, I_G = 1 A,$ Clamped Inductive Load	$I_{D,max} = 6$ @ $V_{DS} \leq V_{DSmax}$	A
Short Circuit Safe Operating Area	SCSOA	$T_{VJ} = 175 °C, I_G = 1 A, V_{DS} = 800 V,$ Non Repetitive	20	μs
Reverse Gate – Source Voltage	V_{SG}		30	V
Reverse Drain – Source Voltage	V_{SD}		40	V
Power Dissipation	P_{tot}	$T_C = 25 °C$	146	W
Storage Temperature	T_{stg}		-55 to 175	$°C$

Electrical Characteristics at $T_j = 175 °C$, unless otherwise specified

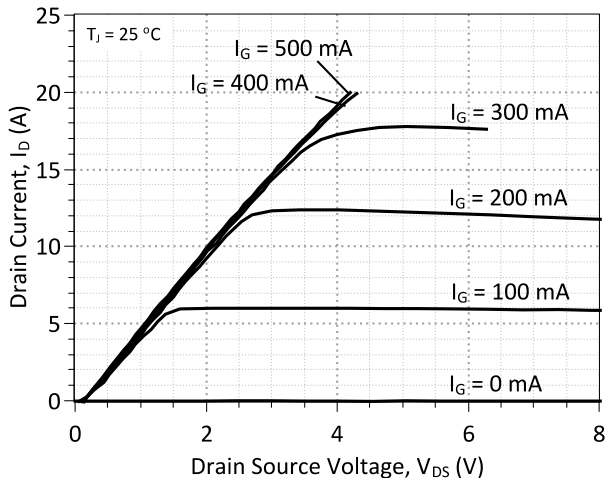
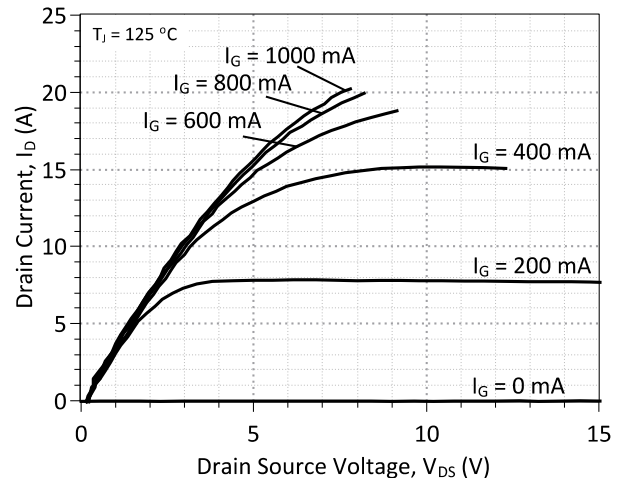
Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
On Characteristics						
Drain – Source On Voltage	$V_{DS(ON)}$	$I_D = 6 A, I_G = 500 mA, T_j = 25 °C$	1.3			V
		$I_D = 6 A, I_G = 1000 mA, T_j = 125 °C$	1.7			
		$I_D = 6 A, I_G = 1000 mA, T_j = 175 °C$	2.2			
Drain – Source On Resistance	$R_{DS(ON)}$	$I_D = 6 A, I_G = 500 mA, T_j = 25 °C$	220			mΩ
		$I_D = 6 A, I_G = 1000 mA, T_j = 125 °C$	280			
		$I_D = 6 A, I_G = 1000 mA, T_j = 175 °C$	370			
Gate Forward Voltage	$V_{GS(FWD)}$	$I_G = 500 mA, T_j = 25 °C$ $I_G = 500 mA, T_j = 175 °C$	3.1 2.9			V
DC Current Gain	β	$V_{DS} = 5 V, I_D = 6 A, T_j = 25 °C$	58			
		$V_{DS} = 5 V, I_D = 6 A, T_j = 175 °C$	33			
Off Characteristics						
Drain Leakage Current	I_{DSS}	$V_R = 1100 V, V_{GS} = 0 V, T_j = 25 °C$	300			nA
		$V_R = 1100 V, V_{GS} = 0 V, T_j = 125 °C$	350			
		$V_R = 1100 V, V_{GS} = 0 V, T_j = 175 °C$	450			
Gate Leakage Current	I_{SG}	$V_{SG} = 20 V, T_j = 25 °C$	20			nA

Electrical Characteristics at $T_j = 175\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit	
			min.	typ.	max.		
Capacitance Characteristics							
Gate-Source Capacitance	C_{GS}	$V_{GS} = 0\text{ V}, f = 1\text{ MHz}$		660		pF	
Input Capacitance	C_{ISS}	$V_{GS} = 0\text{ V}, V_D = 1\text{ V}, f = 1\text{ MHz}$		900		pF	
Reverse Transfer/Output Capacitance	C_{RSS}/C_{OSS}	$V_D = 1\text{ V}, f = 1\text{ MHz}$		240		pF	
Switching Characteristics							
Turn On Delay Time	$t_{d(on)}$	$T_j = 25\text{ }^\circ\text{C}, V_{DD} = 800\text{ V}, I_D = 6\text{ A},$ "Option #1" Gate Drive $R_{G(on)} = R_{G(off)} = 1.5\ \Omega, C_G = 9\text{ nF}$ $V_{GH} = 20\text{ V}, V_{GL} = 6\text{ V}, V_{EE} = -5\text{ V}$ $L = 1.05\text{ mH}, \text{FWD} = \text{GB05SLT12},$ Refer to Figure 15 for gate current waveform		13		ns	
Rise Time, Drain Current	t_r			7		ns	
Turn Off Delay Time	$t_{d(off)}$			54		ns	
Fall Time, Drain Current	t_f			51		ns	
Turn-On Energy Per Pulse	E_{on}			175		μJ	
Turn-Off Energy Per Pulse	E_{off}			44		μJ	
Total Switching Energy	E_{ts}			219		μJ	
Turn On Delay Time	$t_{d(on)}$		$T_j = 175\text{ }^\circ\text{C}, V_{DD} = 800\text{ V}, I_D = 6\text{ A},$ "Option #1" Gate Drive $R_{G(on)} = R_{G(off)} = 1.5\ \Omega, C_G = 9\text{ nF}$ $V_{GH} = 20\text{ V}, V_{GL} = 6\text{ V}, V_{EE} = -5\text{ V}$ $L = 1.05\text{ mH}, \text{FWD} = \text{GB05SLT12},$ Refer to Figure 15 for gate current waveform		11		ns
Rise Time, Drain Current	t_r				8		ns
Turn Off Delay Time	$t_{d(off)}$				79		ns
Fall Time, Drain Current	t_f			45		ns	
Turn-On Energy Per Pulse	E_{on}			159		μJ	
Turn-Off Energy Per Pulse	E_{off}			55		μJ	
Total Switching Energy	E_{ts}			214		μJ	

Thermal Characteristics

Thermal resistance, junction - case	R_{thJC}	1.03	$^\circ\text{C/W}$
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Figures

Figure 1: Typical Output Characteristics at 25 °C

Figure 2: Typical Output Characteristics at 125 °C

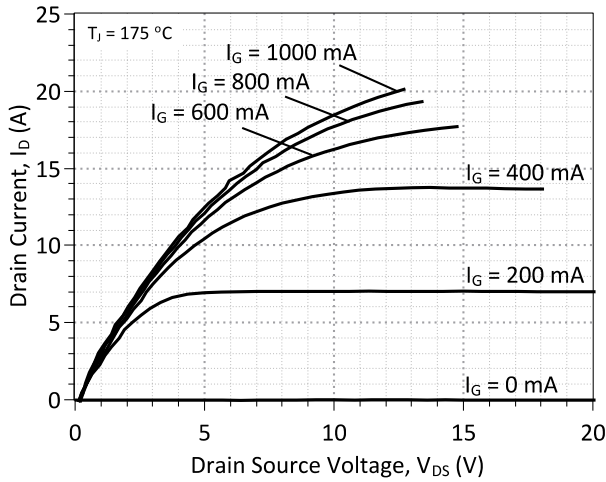


Figure 3: Typical Output Characteristics at 175 °C

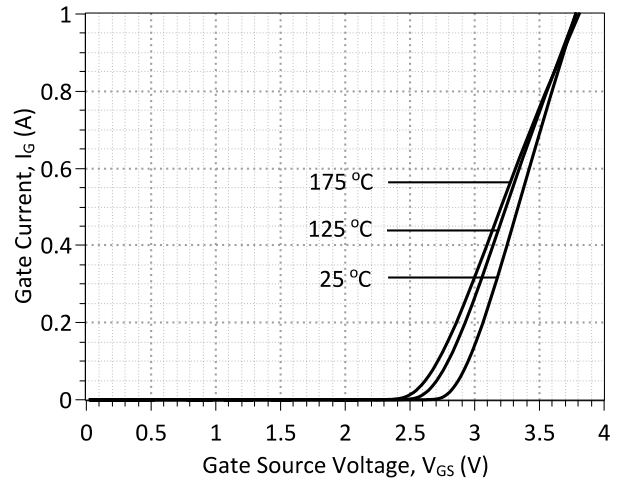


Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

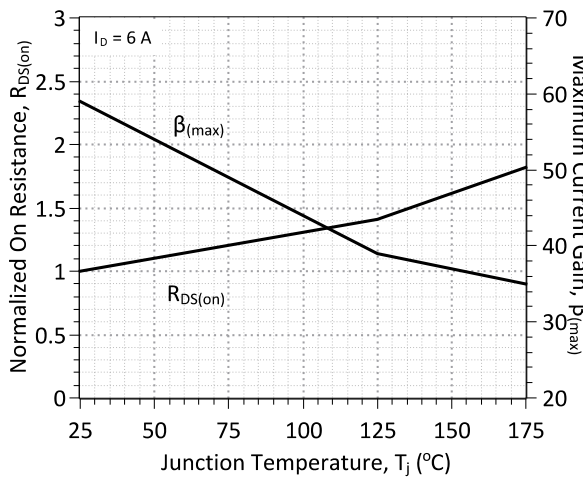


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

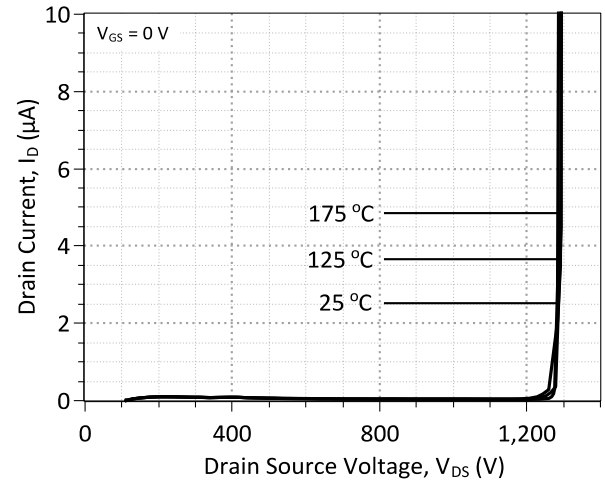


Figure 6: Typical Blocking Characteristics

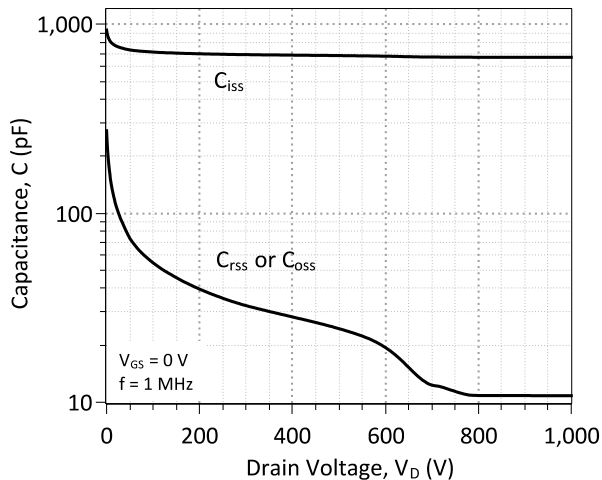


Figure 7: Capacitance Characteristics

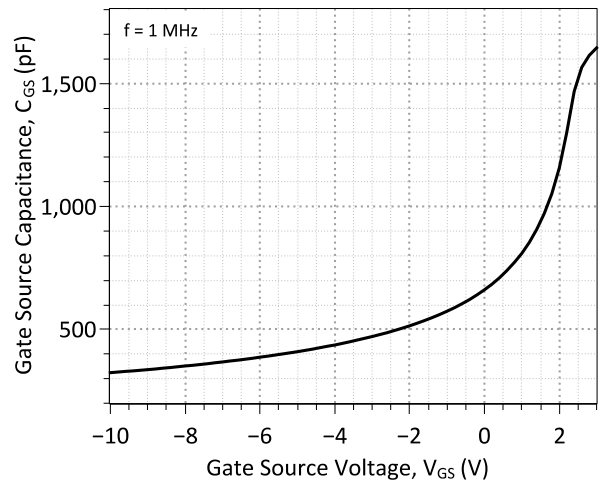


Figure 8: Capacitance Characteristics

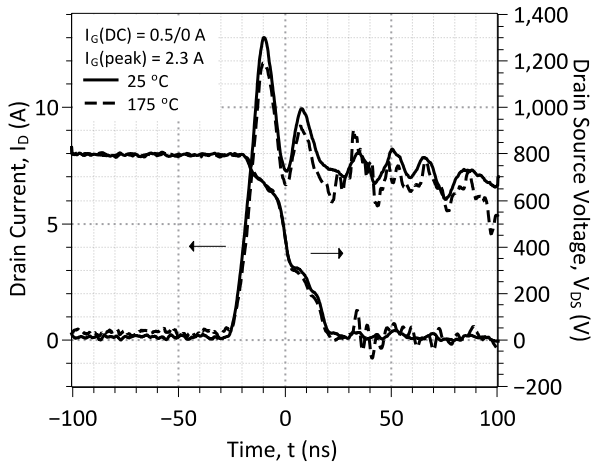


Figure 9: Typical Hard-switched Turn On Waveforms

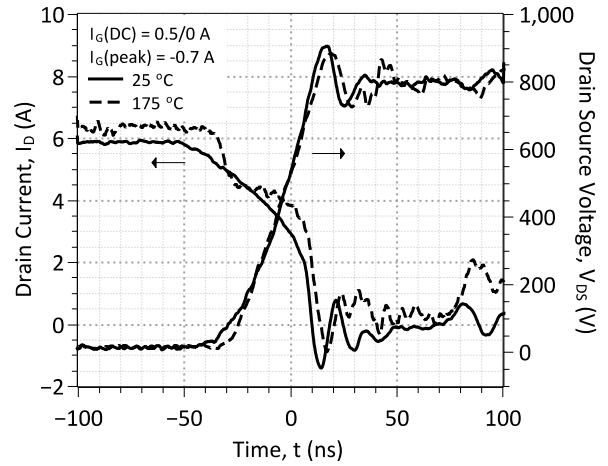


Figure 10: Typical Hard-switched Turn Off Waveforms

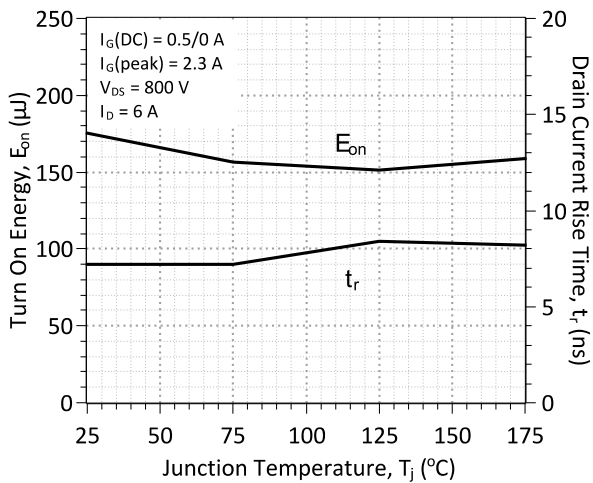


Figure 11: Typical Turn On Energy Losses and Switching Times vs. Temperature

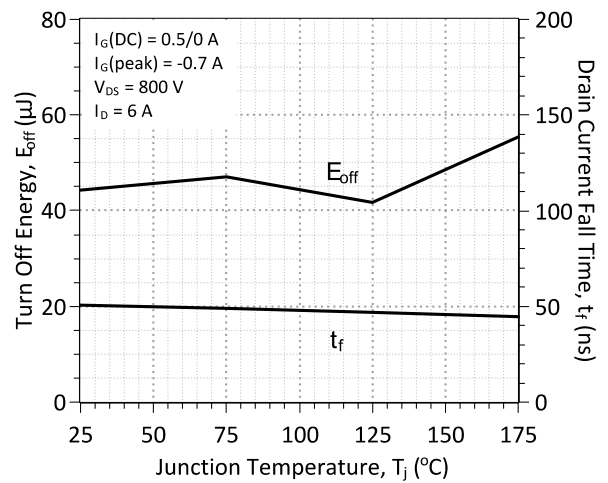


Figure 12: Typical Turn Off Energy Losses and Switching Times vs. Temperature

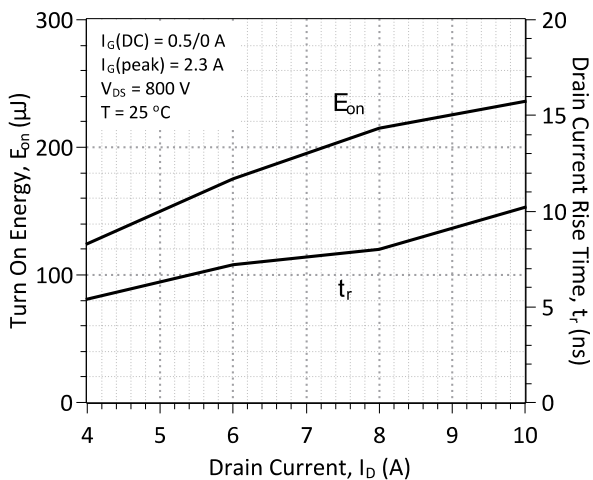


Figure 13: Typical Turn On Energy Losses vs. Drain Current

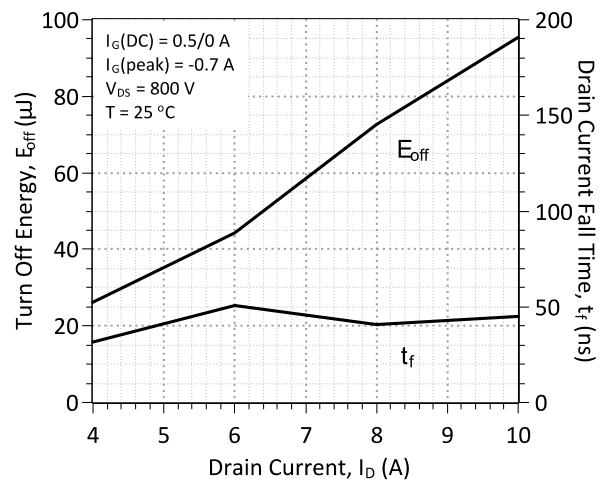


Figure 14: Typical Turn Off Energy Losses vs. Drain Current

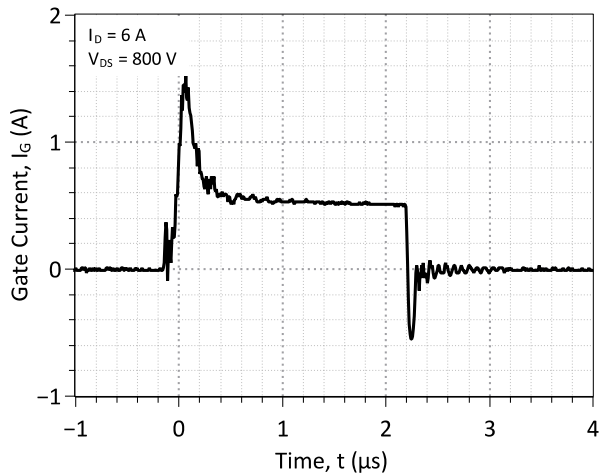


Figure 15: Typical Gate Current Waveform

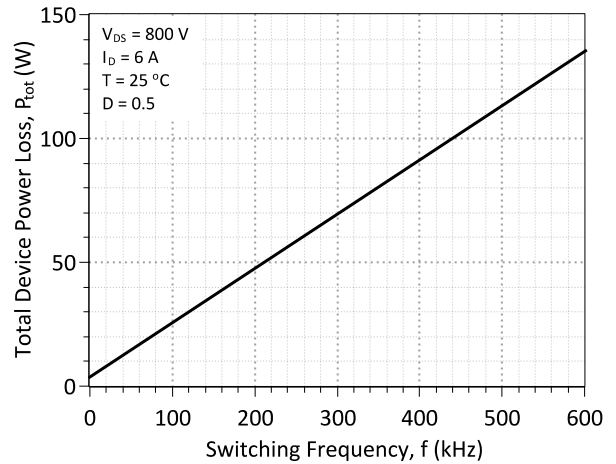


Figure 16: Typical Hard Switched Device Power Loss vs. Switching Frequency¹

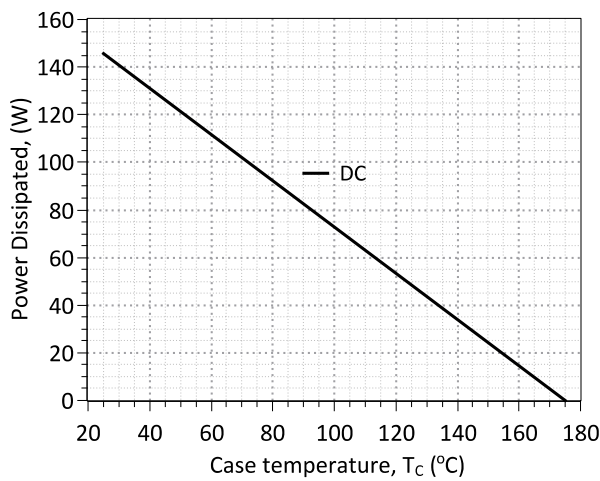


Figure 17: Power Derating Curve

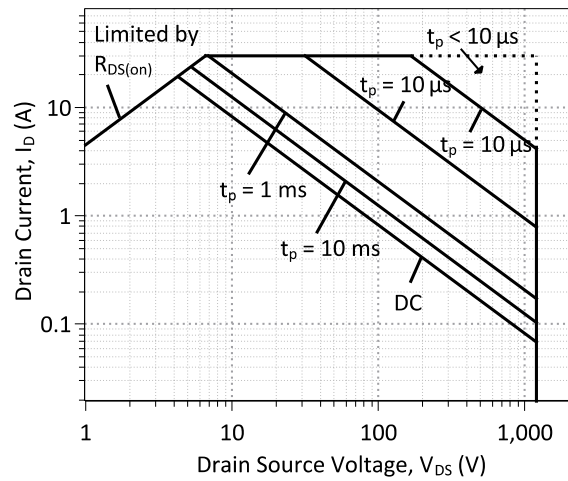


Figure 18: Forward Bias Safe Operating Area

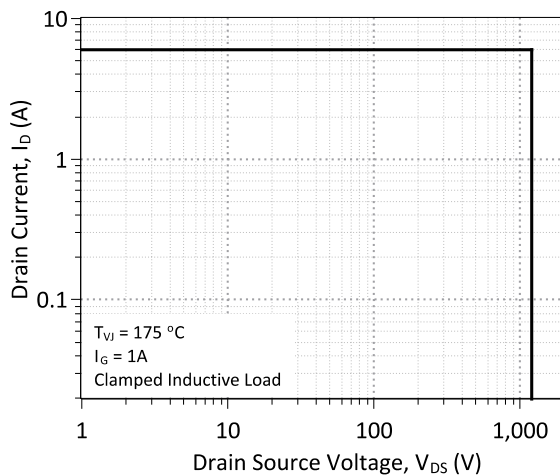


Figure 19: Turn-Off Safe Operating Area

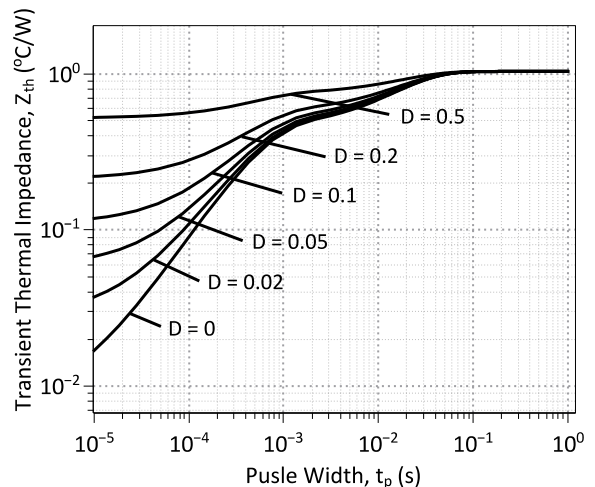


Figure 20: Transient Thermal Impedance

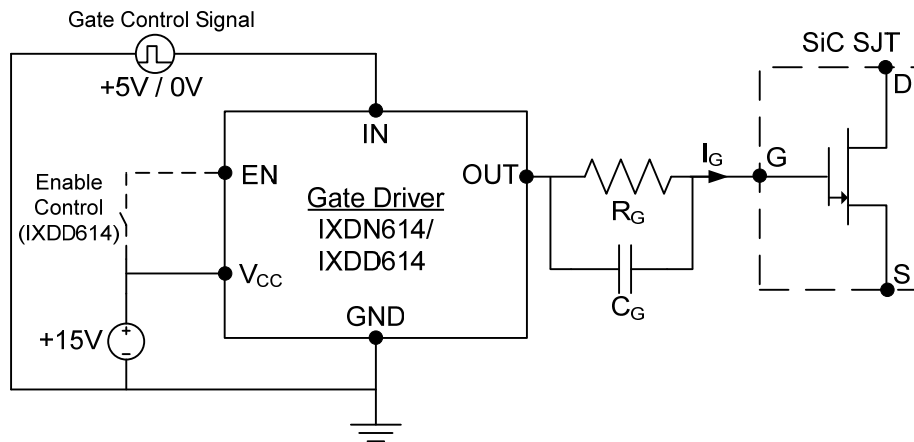
¹ – Representative values based on device switching energy loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.

Gate Drive Technique (Option #1)

To drive the GA06JT12-247 with the lowest gate drive losses, please refer to the dual voltage source gate drive configuration described in Application Note AN-10B (<http://www.genesicsemi.com/index.php/references/notes>).

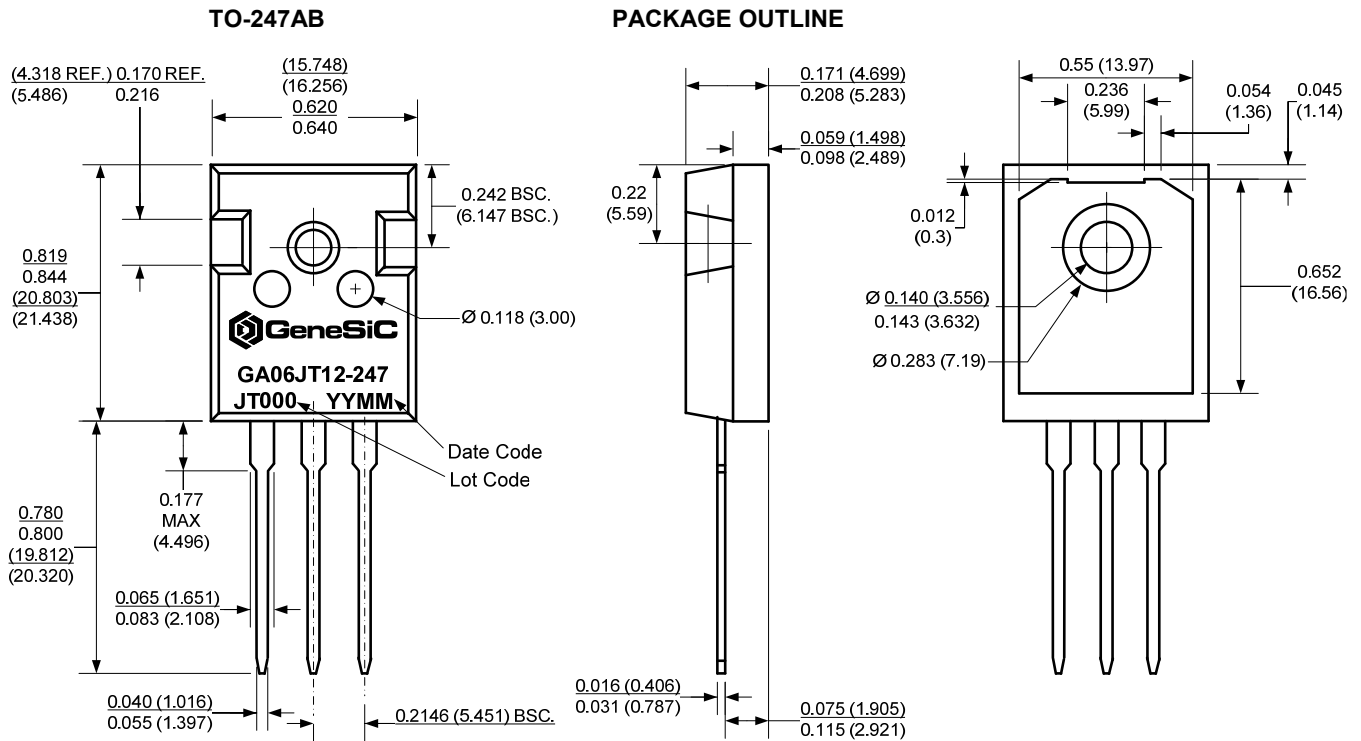
Gate Drive Technique (Option #2)

The GA06JT12-247 can be effectively driven using the IXYS IXDN614 / IXDD614 non-inverting gate driver IC or a comparable product. A typical gate driver configuration along with component values using this driver is offered below. Additional information is available in GeneSiC Application Note AN-10A and from the manufacturer at www.ixys.com.


Figure 21: Gate Diver Configuration (Option #2)

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Option #1 Gate Drive Conditions (IXDD614/IXDN614)						
Supply Voltage, High Side Driver	V_{CC}	V_{GH}	15	20	30	V
Supply Voltage, Low Side Driver	V_{CC}	V_{GL}	5	6		V
Off State Voltage, Both Drivers	GND	V_{EE}		-5	0	V
Gate Control Input Signal, Low	IN		-5.0	0	0.8	V
Gate Control Input Signal, High	IN		4	5.0	$V_{CC}+0.3$	V
Enable, Low	EN	IXDD614 Only			$1/3 * V_{CC}$	V
Enable, High	EN	IXDD614 Only		$2/3 * V_{CC}$		V
Output Voltage, Low	V_{OUT}				0.025	V
Output Voltage, High	V_{OUT}		$V_{CC}-0.025$			V
Output Current, Peak	I_{OUT}	Package Limited			14	A
Output Current, Continuous	I_{OUT}			0.5	4.0	A
Passive Gate Components						
Gate Resistance	R_G	$V_{GL} = 6.0 \text{ V}, I_G \approx 0.5 \text{ A}$		1.6	5	Ω
Gate Capacitance	C_G	$V_{GH} = 20 \text{ V}, I_{G,pk} \approx 2.0 \text{ A}$	5	9		nF

Package Dimensions:



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History			
Date	Revision	Comments	Supersedes
2013/08/23	3	Updated Switching Characteristics	
2013/06/24	2	Updated Electrical Characteristics	
2013/02/21	1	Revised Electrical Characteristics	
2012/11/30	0	Initial Release	

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the GA06JT12 SJT device.

```
*      MODEL OF GeneSiC Semiconductor Inc.
*
*      $Revision:   1.0           $
*      $Date:      26-AUG-2013   $
*
*      GeneSiC Semiconductor Inc.
*      43670 Trade Center Place Ste. 155
*      Dulles, VA 20166
*      http://www.genesicsemi.com/index.php/sic-products/sjt
*
*      COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
*      ALL RIGHTS RESERVED
*
*      These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
*      OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
*      TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
*      PARTICULAR PURPOSE."
*      Models accurate up to 2 times rated drain current.
*
.model GA06JT12 NPN
+ IS      5.08E-47
+ ISE     1.26E-28
+ EG      3.2
+ BF      58.31
+ BR      0.55
+ IKF     200
+ NF      1
+ NE      1.892
+ RB      0.26
+ RE      0.1039
+ RC      0.06188
+ CJC     2.73E-10
+ VJC     3.04
+ MJC     0.448
+ CJE     6.86E-10
+ VJE     2.89
+ MJE     0.466
+ XTI     3
+ XTB     -1.33
+ TRC1    1.90E-2
+ VCEO    1200
+ ICRATING 6
+ MFG     GeneSiC_Semiconductor
*
*      End of GA06JT12 SPICE Model
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